

# Off-state diagnostics with TLE9563/64

## About this document

### Scope and purpose

This application note provides information about the off-state diagnostic features of the TLE9563/64.

It should be used in conjunction with the corresponding datasheet, which contains the full technical details on the device specification and operation.

### Intended audience

Developers working with the TLE9563/64 devices.

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1 Introduction

1 Introduction

The motor system *integrated circuit (IC)* family (TLE9563/64) is a multi half-bridge MOSFET driver, which combines power, communication and supply. All devices feature a low-dropout voltage regulator with an output current of 250 mA/5 V. The communication interface incorporates a *controller area network (CAN) FD* transceiver up to 5 Mbit/s according to ISO 11898-2:2016 (including partial networking option) and/or LIN transceiver. All devices are available in a VQFN-48 (7 mm x 7 mm) package.

The devices offer a wide range of diagnostic features for the bridge driver both in on-state and in off-state. This application note focuses on the off-state diagnostic features.

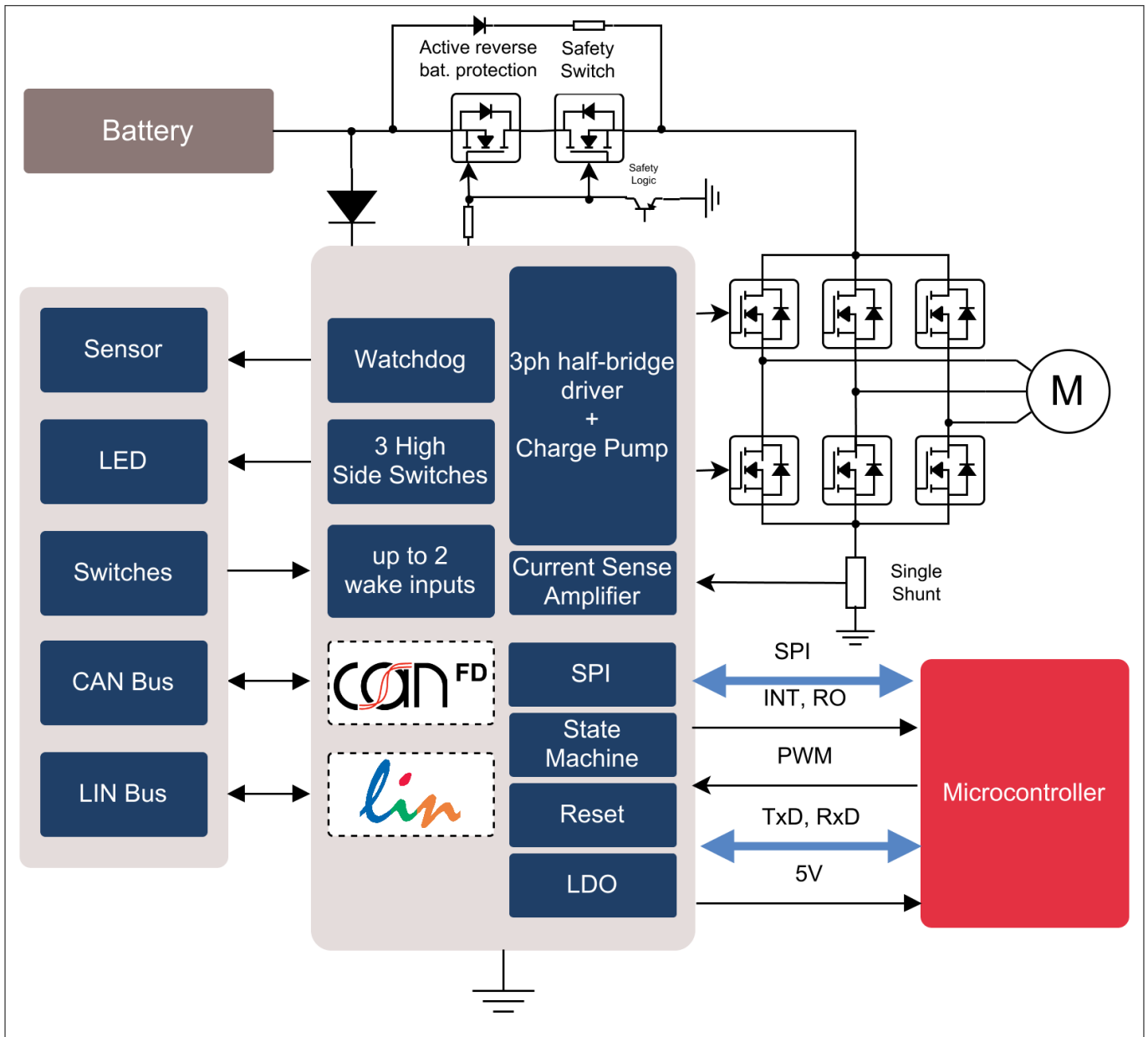


Figure 1 TLE9563/64 application diagram

## 2 Off-state diagnostic general principles

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### 2.1 Benefits

The off-state diagnostic feature (for example: when the MOSFETs are off while the diagnostic is performed) has several advantages:

- Diagnostic checks can be regularly performed, even for loads that are infrequently activated
- MOSFET short circuits are detected without the stress that is inherent to the on-state diagnostic mode (on-state diagnostic is also available for TLE9563/64). For example, the microcontroller can perform an off-state diagnostic immediately before the activation request. Upon the fault condition, the application software can report the failure and inhibits the load activation, avoiding any stress to the MOSFETs

### 2.2 Required settings

The bridge driver is activated and the associated MOSFETs are off:

- The device is in normal mode
- The bridge driver is in active mode: CPEN = 1<sub>B</sub> (charge pump enabled)
- The MOSFETs are actively kept off: HBxMODE[1:0] = 11<sub>B</sub>
- It is highly recommended to set the drain-source overvoltage threshold ( $V_{DSMONTH}$ ) of the diagnosed half-bridge to its maximum value for a robust diagnostic: HBxVDSTH[2:0] = 111<sub>B</sub>,  $V_{DSMONTH} = 2\text{ V typ.}$  (datasheet parameter  $V_{DSMONTH7\_CPON}$ )\*

**Note:** *\*It is recommended to restore the setting of  $V_{DSMONTH}$  once the off-state diagnostic is performed for an appropriate MOSFET protection in on-state.*

### 2.3 Detectable failures by the off-state diagnostic

The TLE9563/64 enables the detection of the following fault conditions while the MOSFETs are deactivated:

- Short-circuit between SHx and VBAT
- Short-circuit between SHx and *ground (GND)*
- Open load

SHx designates the output of the half-bridge x, VBAT is the battery voltage.

### 2.4 Theory of operation

Figure 2 shows the block diagram of the gate drivers of one half-bridge. The following integrated components are used to perform the off-state diagnostic:

- Pull-up diagnostic current ( $I_{PUDIAG}$ )
- Pull-down diagnostic current ( $I_{PDDIAG}$ )
- Comparator for the high-side drain-source overvoltage

**Note:**  *$I_{PUDIAG}$  is a by-product of the drain-source overvoltage monitoring for each high-side MOSFET. It is automatically activated when the bridge driver is in active mode (CPEN = 1<sub>B</sub> and the considered half-bridge is actively kept off: HBxMODE[1:0] = 11<sub>B</sub>)*

2 Off-state diagnostic general principles

**Note:**  $I_{PDDIAG}$  can be individually activated for each half-bridge only if the bridge driver is activated and the considered half-bridge is actively kept off

By design  $I_{PDDIAG} > 4.25 \times I_{PUDIAG}$ . Typically  $I_{PUDIAG} = 400 \mu A$ ,  $I_{PDDIAG} = 2200 \mu A$ .

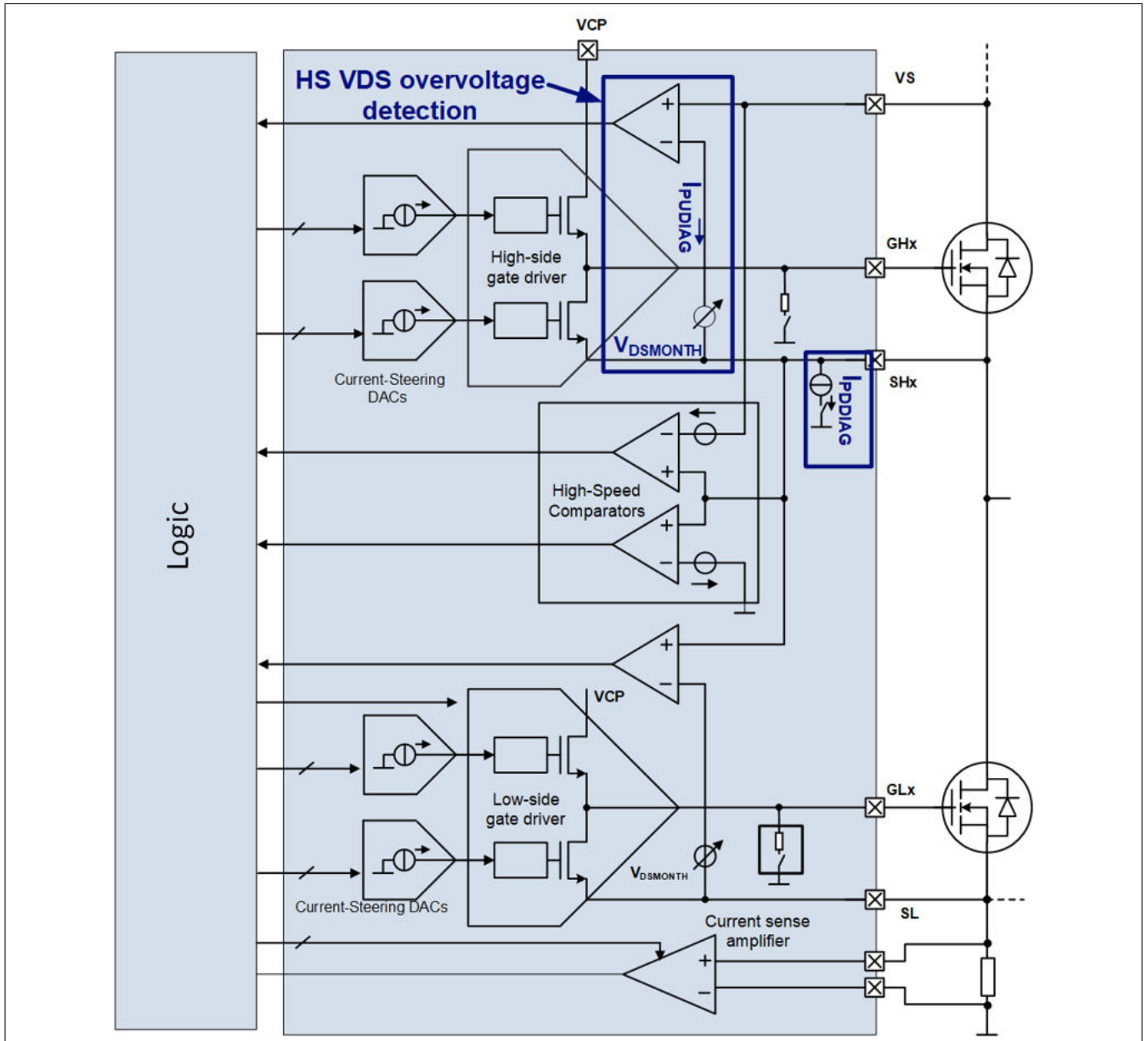


Figure 2 Block diagram of one half-bridge gate driver

The TLE9563/64 determines the voltage at SHx, using the drain-source overvoltage comparators of the high-side MOSFETs. The microcontroller can read the status bits HBxVOUT to determine if VSHx is high or low. The diagnostic process is controlled by the microcontroller, and is tasked with:

- Activating and deactivating  $I_{PDDIAG}$ , (refer to the control bits HBxIDIAG)
- Reading and interpreting the status bits HBxVOUT according to the setting of  $I_{PDDIAG}$

2.5 Conventions

The following conditions are equivalent in the rest of this document:

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## 2 Off-state diagnostic general principles

- HBxVOUT = 0:  $V_{SHx}$  is low ( $V_S - V_{SHx} > V_{DSMONTH}$ )
- HBxVOUT = 1:  $V_{SHx}$  is high ( $V_S - V_{SHx} < V_{DSMONTH}$ )

$V_S$  designates the voltage applied to the *voltage supply (VS)* pin. In particular, it is also the drain voltage of the high-side MOSFETs.

- HBxIDIAG = 0:  $I_{PDDIAG}$  of HBx is off
- HBxIDIAG = 1:  $I_{PDDIAG}$  of HBx is on

3 Off-state diagnostic

3 Off-state diagnostic

The proposed principle consists in analyzing  $V_{SHx}$  in the different load conditions, when all pull-down diagnostic currents are deactivated, and when two out of three pull-down diagnostic currents are activated.

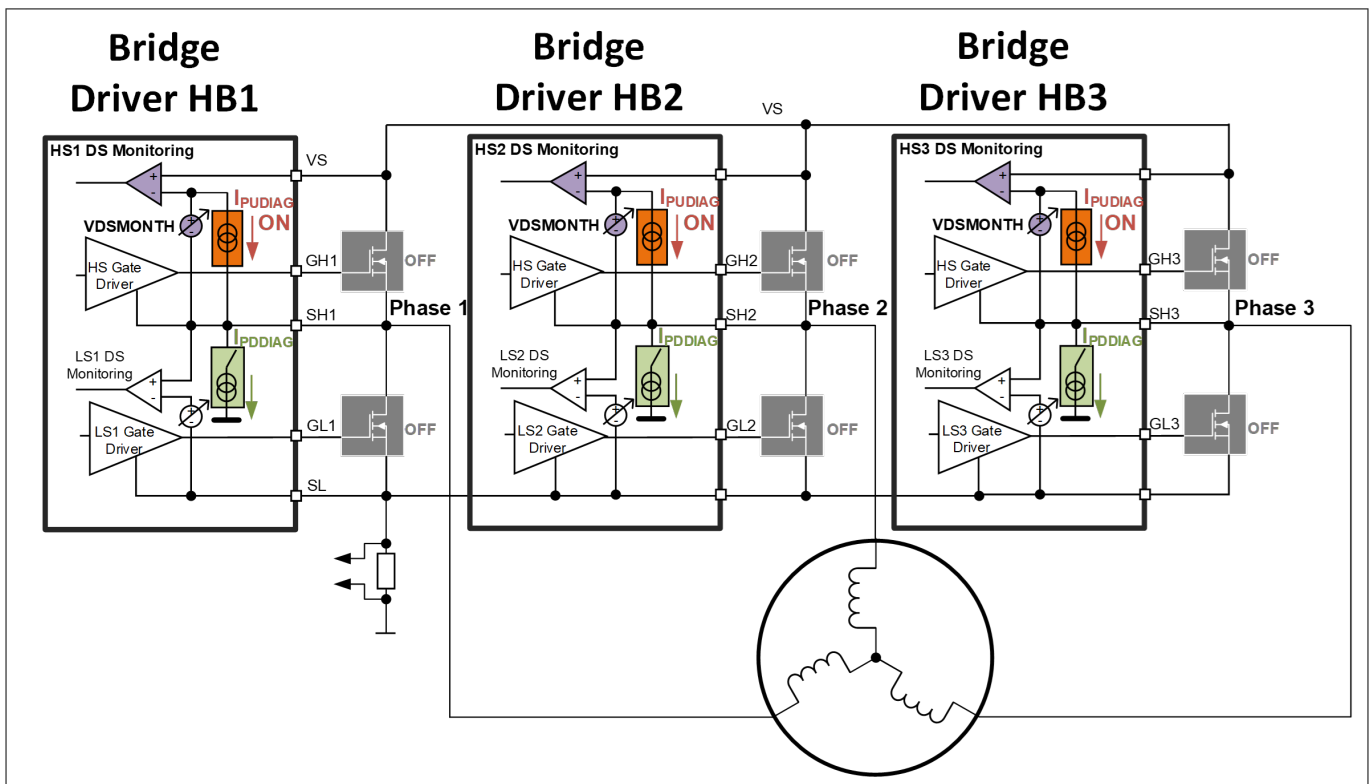
**Note:** An off-state diagnostic activating one pull-down out of three is also possible, considering that  $I_{PDDIAG} > 4.25 \times I_{PUDIAG}$ . Consequently, one single pull-down is stronger than the sum of the three pull-ups. However, the net pull-down current in normal conditions is  $I_{PDDIAG} - 3 \times I_{PUDIAG}$  (compared to  $2 \times I_{PDDIAG} - 3 \times I_{PUDIAG}$  when two pull-down currents are activated). Therefore the net discharge current is lower and the settling time for discharging output capacitors is longer.

**Table 1 Configurations of the pull-down diagnostic currents**

Pull-down configuration	$I_{PDDIAG}$ HB1	$I_{PDDIAG}$ HB2	$I_{PDDIAG}$ HB3
Configuration 1	OFF	OFF	OFF
Configuration 2	ON	ON	OFF
Configuration 3	OFF	ON	ON
Configuration 4	ON	OFF	ON

3.1 Normal condition

It is assumed that the motor is correctly connected without any short circuit between SHx and VBAT or GND.



**Figure 3 Off-state diagnostic in normal load conditions, CPEN = 1, HBxMODE[1:0] = 11B**

**Condition: 1  $I_{PDDIAG}$  HB1 OFF,  $I_{PDDIAG}$  HB2 OFF,  $I_{PDDIAG}$  HB3 OFF**

No pull-down is activated. Therefore SH1, SH2 and SH3 are pulled up by the  $I_{PUDIAG}$  of each half-bridges. Refer to Figure 4.

3 Off-state diagnostic

$$V_{SH1} = V_{SH2} = V_{SH3} = \text{High}$$

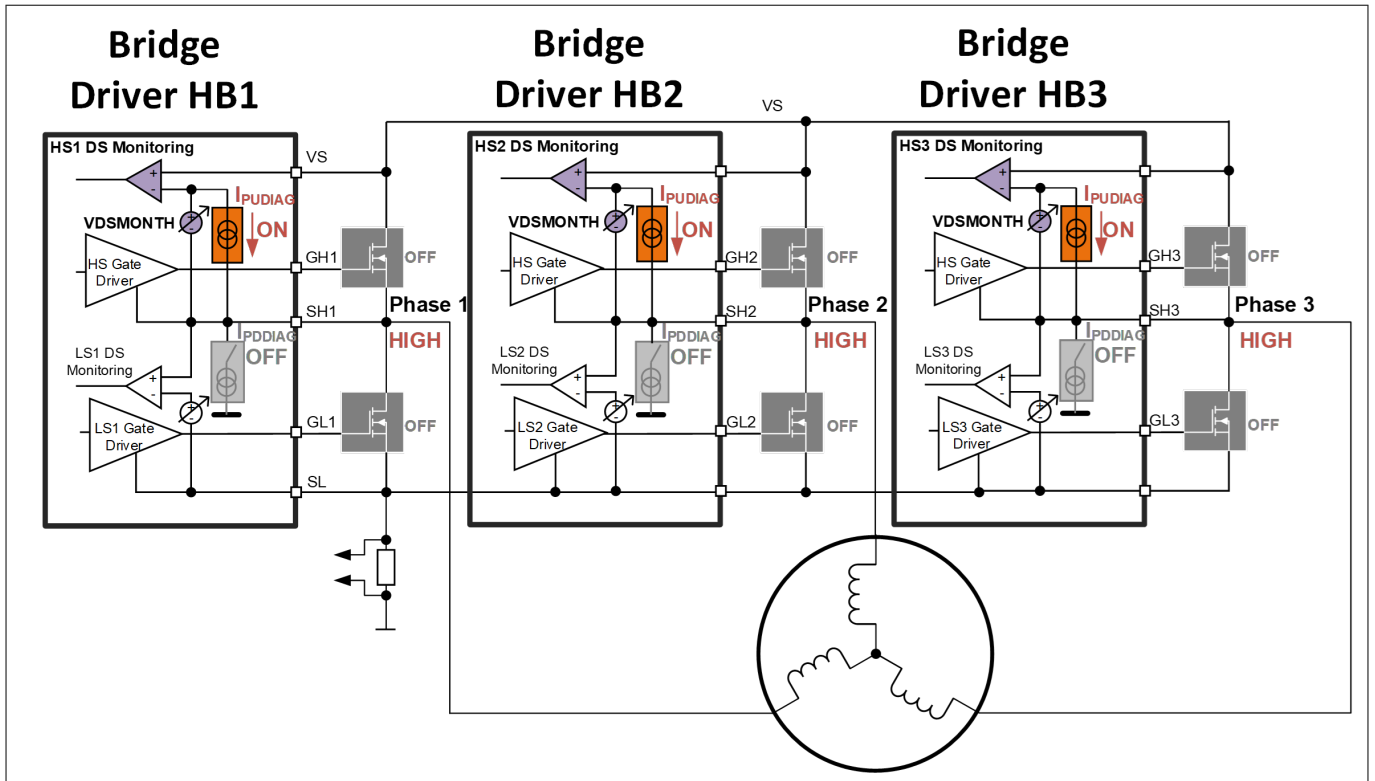


Figure 4 Normal load conditions in configuration 1

Configuration 2:  $I_{PDDIAG}$  HB1 ON,  $I_{PDDIAG}$  HB2 ON,  $I_{PDDIAG}$  HB3 OFF

By design  $I_{PDDIAG} > 4.25 \times I_{PUDIAG}$ . When the pull-down and pull-up diagnostic currents of a half-bridge are activated (for example HB1 and HB2 in Configuration 2), it results in a net pull-down current in the considered half-bridge equal to  $I_{PDDIAG} - I_{PUDIAG}$ . The net pull-down current in Configuration 2 is  $2 \times I_{PDDIAG} - 3 \times I_{PUDIAG}$ , therefore  $V_{SH1} = V_{SH2} = V_{SH3} = \text{low}$ .

**Note:** SH3 is also pulled to GND by  $I_{PDDIAG}$  of HB1 and HB2 through the motor windings  $\rightarrow V_{SH3} = \text{low}$ .



3 Off-state diagnostic

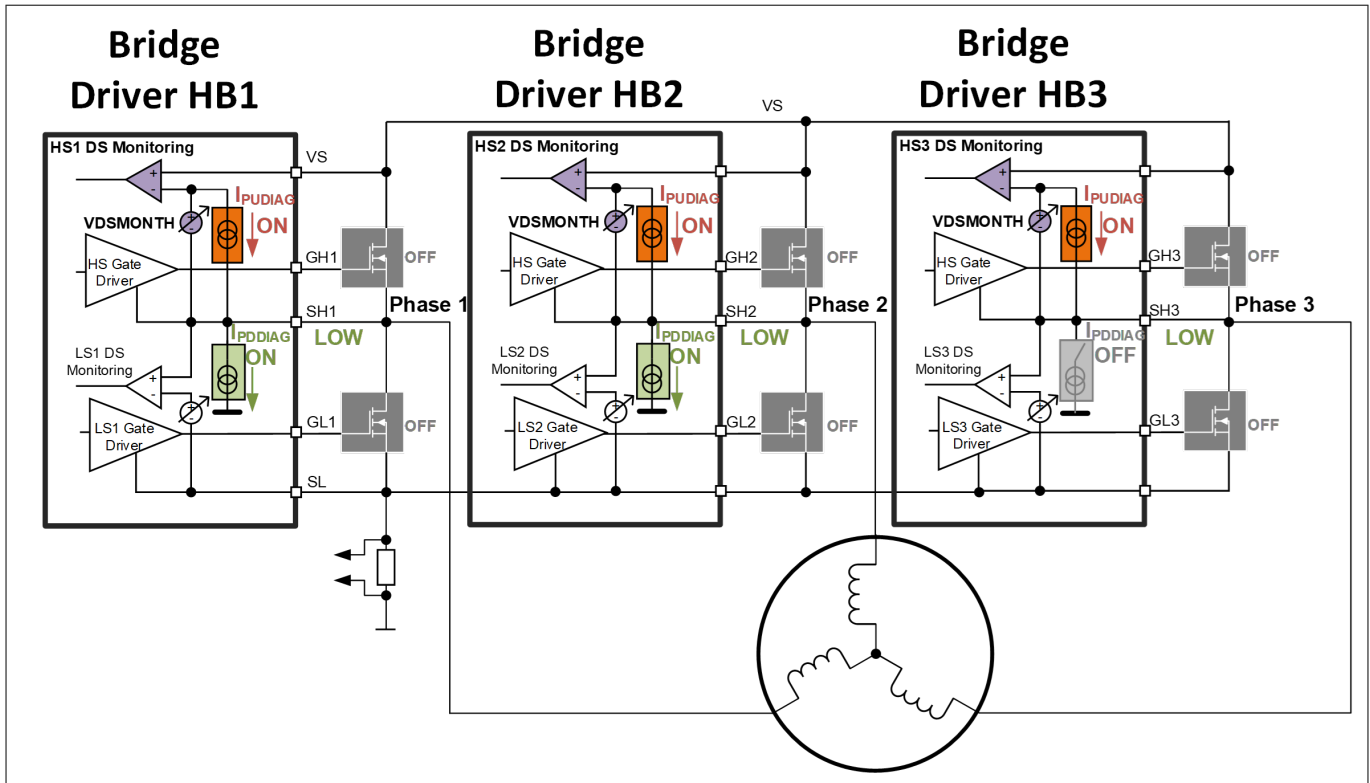


Figure 5 Normal load conditions in configuration 2

**Note:** When capacitors are connected to SHx (for example: electrostatic discharge (ESD) capacitors placed on the PCB, or filter capacitors located in the motors), these capacitors are charged/discharged by the sum of the diagnostic currents of each half-bridge. Therefore, the application must take into consideration the charge/discharge times for a valid determination of the voltage level at the SHx pins

Configuration 3 and configuration 4:

As,  $V_{SH1} = V_{SH2} = V_{SH3} = \text{low}$  in configuration 3 and configuration 4

Table 2 summarizes the results obtained in normal conditions.

Table 2 Truth table with normal load conditions

Pull-down configuration	$I_{PDDIAG}$ HB1	$I_{PDDIAG}$ HB2	$I_{PDDIAG}$ HB3	$V_{SH1}$	$V_{SH2}$	$V_{SH3}$
Configuration 1	OFF	OFF	OFF	High	High	High
Configuration 2	ON	ON	OFF	Low	Low	Low
Configuration 3	OFF	ON	ON	Low	Low	Low
Configuration 4	ON	OFF	ON	Low	Low	Low

3.2 Short circuit to VBAT

A short circuit between one of the phases and VBAT results in  $V_{SH1} = V_{SH2} = V_{SH3} = \text{high}$ , independently from the activation of  $I_{PDDIAG}$ . Table 3 summarizes the results obtained with a short circuit of one phase to VBAT.

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**Table 3 Truth table with a short circuit to VBAT**

Pull-down configuration	$I_{PDDIAG\ HB1}$	$I_{PDDIAG\ HB2}$	$I_{PDDIAG\ HB3}$	$V_{SH1}$	$V_{SH2}$	$V_{SH3}$
Configuration 1	OFF	OFF	OFF	High	High	High
Configuration 2	ON	ON	OFF	High	High	High
Configuration 3	OFF	ON	ON	High	High	High
Configuration 4	ON	OFF	ON	High	High	High

**3.3 Short circuit to GND**

A short circuit between one of the phases and **GND** results in  $V_{SH1} = V_{SH2} = V_{SH3} = \text{Low}$ , even if all  $I_{PDDIAG}$  are deactivated. [Table 4](#) summarizes the results obtained with a short circuit of one phase to GND.

**Table 4 Short circuit to GND**

Pull-down configuration	$I_{PDDIAG\ HB1}$	$I_{PDDIAG\ HB2}$	$I_{PDDIAG\ HB3}$	$V_{SH1}$	$V_{SH2}$	$V_{SH3}$
Configuration 1	OFF	OFF	OFF	Low	Low	Low
Configuration 2	ON	ON	OFF	Low	Low	Low
Configuration 3	OFF	ON	ON	Low	Low	Low
Configuration 4	ON	OFF	ON	Low	Low	Low

**3.4 Open load conditions**

This chapter describes a method to detect open load failures.

**3.4.1 Disconnected phase at SH3**

This section proposes to detect an open load failure at SH3, by analyzing the  $V_{SHx}$  levels in the different pull-down configurations.

**Configuration 1:  $I_{PDDIAG\ HB1}$  OFF,  $I_{PDDIAG\ HB2}$  OFF,  $I_{PDDIAG\ HB3}$  OFF**

SH1, SH2 and SH3 are pulled up by their pull-up diagnostic currents:  $V_{SH1} = V_{SH2} = V_{SH3} = \text{High}$

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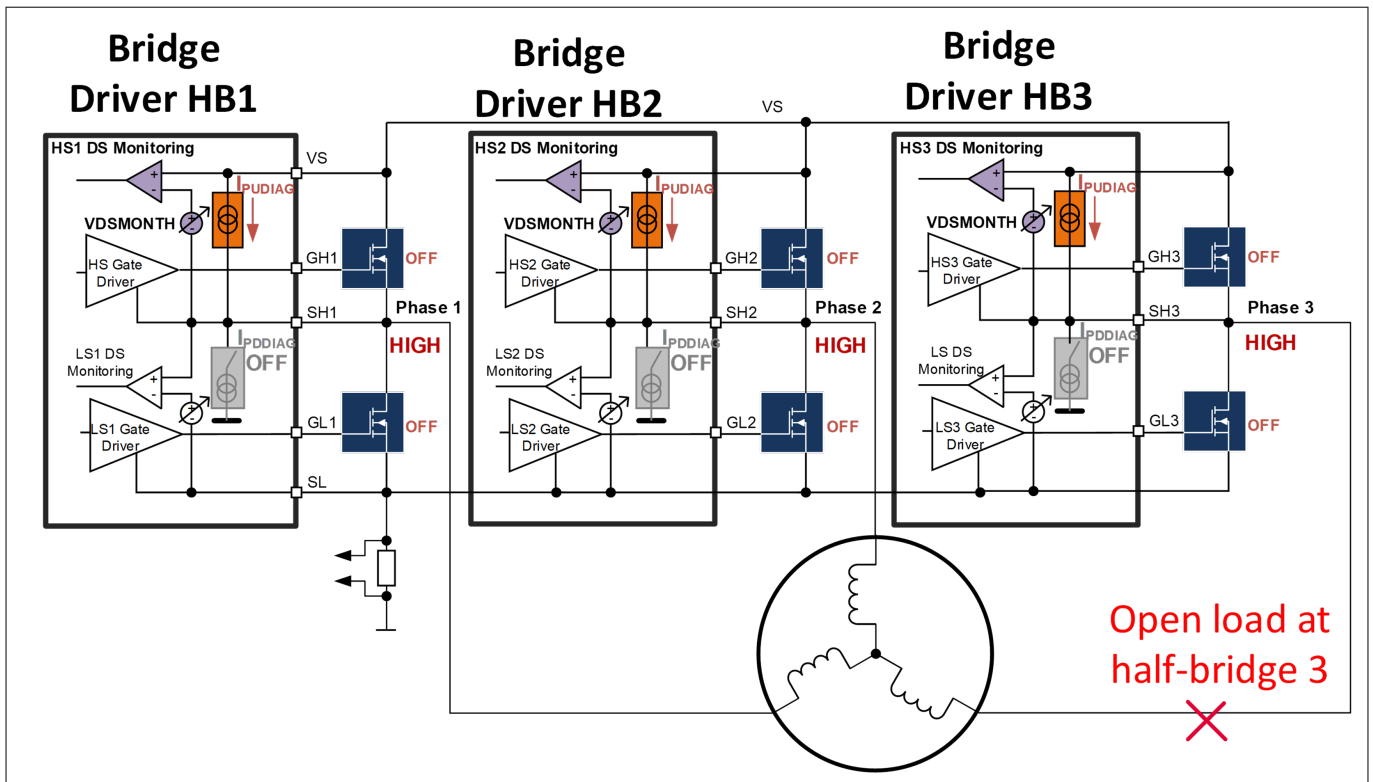


Figure 6 Open load conditions at SH3 in configuration 1

Configuration 2: I<sub>PDDIAG</sub> HB1 ON, I<sub>PDDIAG</sub> HB2 ON, I<sub>PDDIAG</sub> HB3 OFF

SH1 and SH2 are pulled down by the net pull-down current  $2 \times I_{PDDIAG} - 2 \times I_{PUDIAG}$ :  $V_{SH1} = V_{SH2} = \text{low}$   
 Due to the disconnection at the phase 3, SH3 is pulled up by I<sub>PUDIAG</sub> of HB3:  $V_{SH3} = \text{high}$

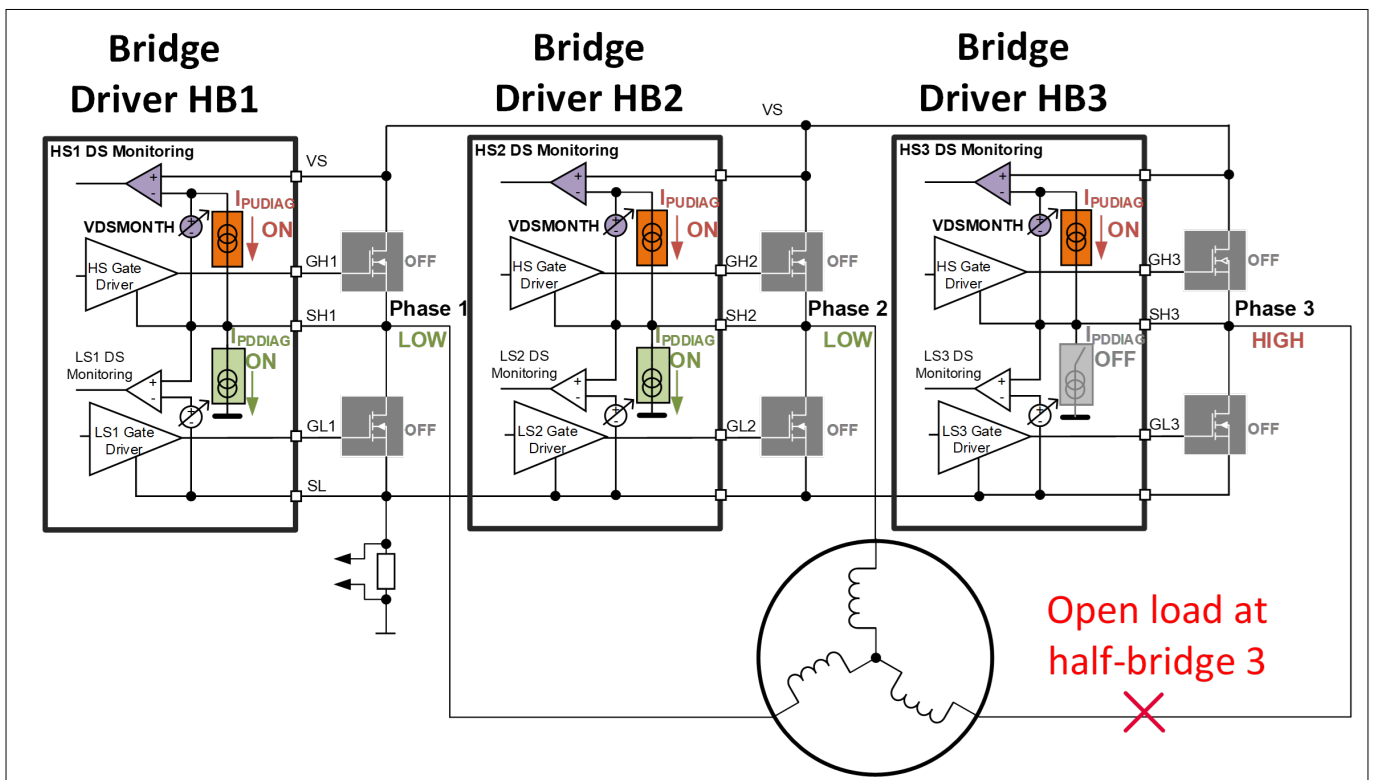
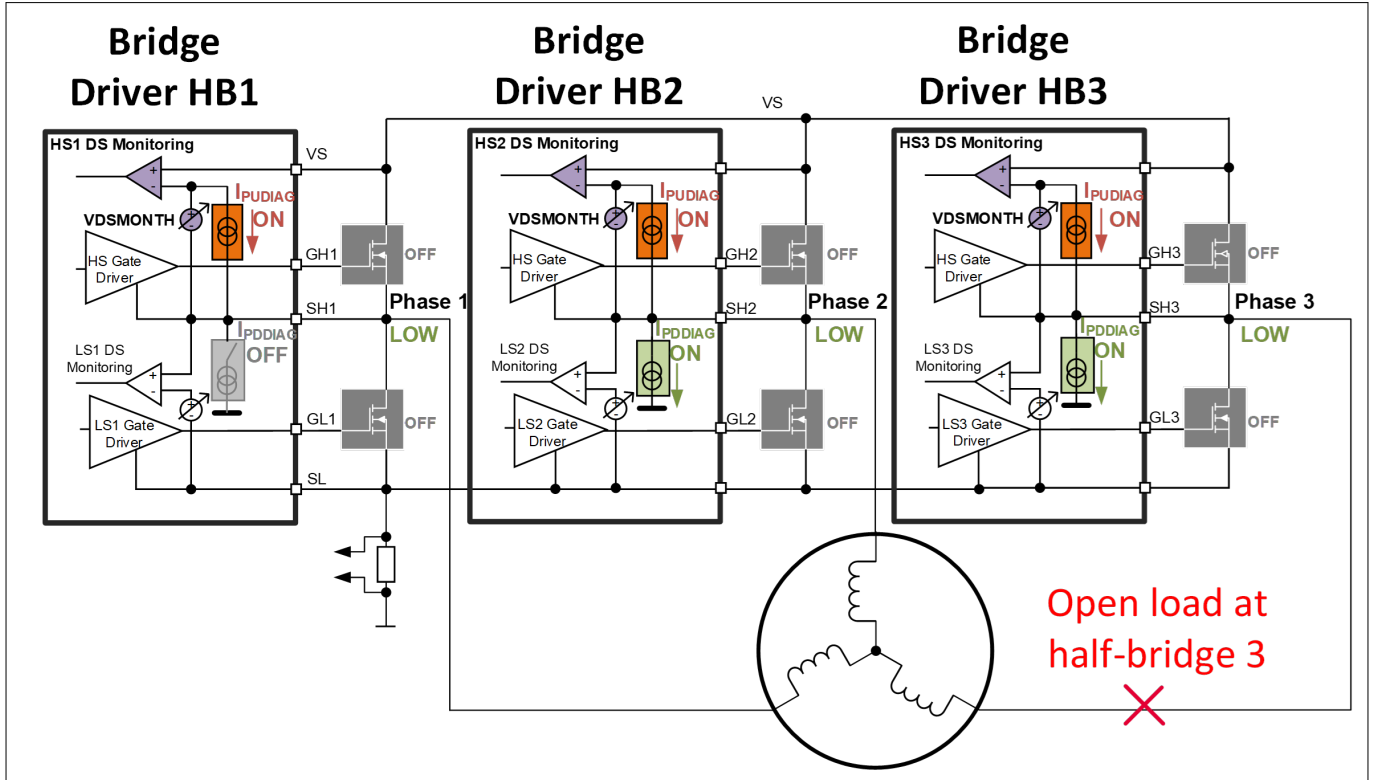


Figure 7 Open load conditions at SH3 in configuration 2

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**Configuration 3:  $I_{PDDIAG}$  HB1 OFF,  $I_{PDDIAG}$  HB2 ON,  $I_{PDDIAG}$  HB3 ON**

SH1 and SH2 are pulled down by the net pull-down current  $I_{PDDIAG} - 2 \times I_{PUDIAG}$ :  $V_{SH1} = V_{SH2} = \text{low}$   
 SH3 is pulled down by  $I_{PDDIAG}$  of HB3 (the net pull-down current is  $I_{PDDIAG} - I_{PUDIAG}$ ):  $V_{SH3} = \text{low}$



**Figure 8** Open load conditions at SH3 in configuration 3

3 Off-state diagnostic

Configuration 4:  $I_{PDDIAG}$  HB1 ON,  $I_{PDDIAG}$  HB2 OFF,  $I_{PDDIAG}$  HB3 ON

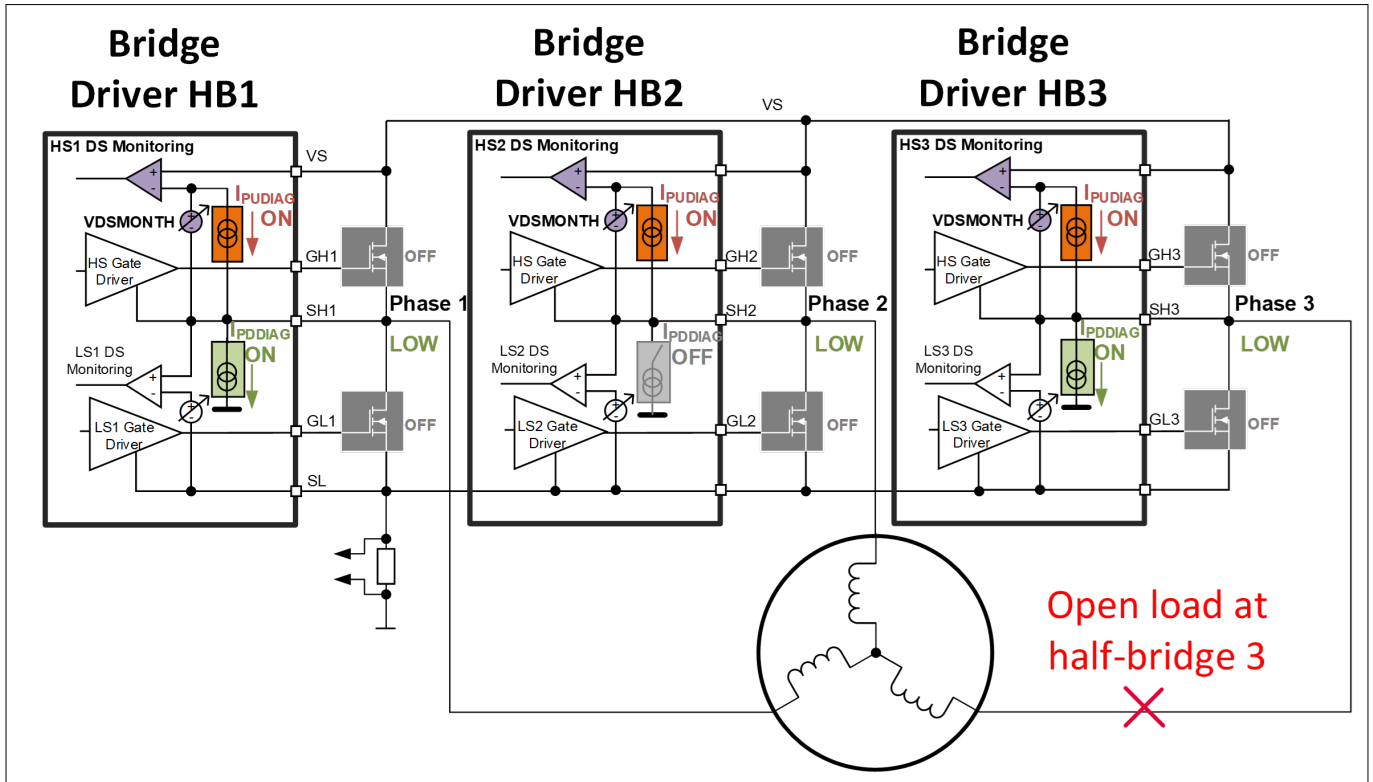


Figure 9 Open load conditions at SH3 in configuration 4

Table 5 summarizes the results obtained in case of an open load failure at SH3.

Table 5 Truth table – open load at SH3

Pull-down configuration	$I_{PDDIAG}$ HB1	$I_{PDDIAG}$ HB2	$I_{PDDIAG}$ HB3	$V_{SH1}$	$V_{SH2}$	$V_{SH3}$
Config 1	OFF	OFF	OFF	High	High	High
Config 2	ON	ON	OFF	Low	Low	High
Config 3	OFF	ON	ON	Low	Low	Low
Config 4	ON	OFF	ON	Low	Low	Low

3.4.2 Summary of the off-state diagnostic with open load conditions

Table 6 summarizes the analysis done in Disconnected phase at SH3 and extends the truth table to open load failures at SH1 and SH2 with the pull-down configurations shown in table 1.

Table 6 Truth table – open load at SH1, SH2 and SH3 using the pull-down configurations 1 to 4

Load conditions	Pull-down configuration	$I_{PDDIAG}$ HB1	$I_{PDDIAG}$ HB2	$I_{PDDIAG}$ HB3	$V_{SH1}$	$V_{SH2}$	$V_{SH3}$
OL* at SH1	Config 1	OFF	OFF	OFF	HIGH	HIGH	HIGH
	Config 2	ON	ON	OFF	LOW	LOW	LOW

(table continues...)

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**Table 6** (continued) Truth table – open load at SH1, SH2 and SH3 using the pull-down configurations 1 to 4

Load conditions	Pull-down configuration	$I_{PDDIAG\ HB1}$	$I_{PDDIAG\ HB2}$	$I_{PDDIAG\ HB3}$	$V_{SH1}$	$V_{SH2}$	$V_{SH3}$
	Config 3	OFF	ON	ON	HIGH	LOW	LOW
	Config 4	ON	OFF	ON	LOW	LOW	LOW
OL* at SH2	Config 1	OFF	OFF	OFF	HIGH	HIGH	HIGH
	Config 2	ON	ON	OFF	LOW	LOW	LOW
	Config 3	OFF	ON	ON	LOW	LOW	LOW
	Config 4	ON	OFF	ON	LOW	HIGH	LOW
OL* at SH3	Config 1	OFF	OFF	OFF	HIGH	HIGH	HIGH
	Config 2	ON	ON	OFF	LOW	LOW	HIGH
	Config 3	OFF	ON	ON	LOW	LOW	LOW
	Config 4	ON	OFF	ON	LOW	LOW	LOW

**Note:** \*OL: Open load

Table 7 shows the diagnostic results of an open load failure when one single pull-down is activated at a time.

**Table 7** Truth table – open load at SH1, SH2 and SH3. One pull-down is activated at a time

Load conditions	$I_{PDDIAG\ HB1}$	$I_{PDDIAG\ HB2}$	$I_{PDDIAG\ HB3}$	$V_{SH1}$	$V_{SH2}$	$V_{SH3}$
OL at SH1	OFF	OFF	OFF	HIGH	HIGH	HIGH
	ON	OFF	OFF	LOW	HIGH	HIGH
	OFF	ON	OFF	HIGH	LOW	LOW
	OFF	OFF	ON	HIGH	LOW	LOW
OL at SH2	OFF	OFF	OFF	HIGH	HIGH	HIGH
	ON	OFF	OFF	LOW	HIGH	LOW
	OFF	ON	OFF	HIGH	LOW	HIGH
	OFF	OFF	ON	LOW	HIGH	LOW
OL at SH3	OFF	OFF	OFF	HIGH	HIGH	HIGH
	ON	OFF	OFF	LOW	LOW	HIGH
	OFF	ON	OFF	LOW	LOW	HIGH
	OFF	OFF	ON	HIGH	HIGH	LOW

**3.5 Summary of the off-state diagnostic**

Table 8 shows the diagnostic results with the different loads conditions. Each load condition has a different signature. It enables a distinction between a normal load condition, from a short circuit to GND/VBAT and an open load failure.

## 3 Off-state diagnostic

**Table 8 Truth table – off-state diagnostic summary**

Load conditions	Pull-down configuration	$I_{PDDIAG\ HB1}$	$I_{PDDIAG\ HB2}$	$I_{PDDIAG\ HB3}$	$V_{SH1}$	$V_{SH2}$	$V_{SH3}$
Normal load	Config 1	OFF	OFF	OFF	HIGH	HIGH	HIGH
	Config 2	ON	ON	OFF	LOW	LOW	LOW
	Config 3	OFF	ON	ON	LOW	LOW	LOW
	Config 4	ON	OFF	ON	LOW	LOW	LOW
Short-circuit to VBAT	Config 1	OFF	OFF	OFF	HIGH	HIGH	HIGH
	Config 2	ON	ON	OFF	HIGH	HIGH	HIGH
	Config 3	OFF	ON	ON	HIGH	HIGH	HIGH
	Config 4	ON	OFF	ON	HIGH	HIGH	HIGH
Short-circuit to GND	Config 1	OFF	OFF	OFF	LOW	LOW	LOW
	Config 2	ON	ON	OFF	LOW	LOW	LOW
	Config 3	OFF	ON	ON	LOW	LOW	LOW
	Config 4	ON	OFF	ON	LOW	LOW	LOW
OL at SH1	Config 1	OFF	OFF	OFF	HIGH	HIGH	HIGH
	Config 2	ON	ON	OFF	LOW	LOW	LOW
	Config 3	OFF	ON	ON	HIGH	LOW	LOW
	Config 4	ON	OFF	ON	LOW	LOW	LOW
OL at SH2	Config 1	OFF	OFF	OFF	HIGH	HIGH	HIGH
	Config 2	ON	ON	OFF	LOW	LOW	LOW
	Config 3	OFF	ON	ON	LOW	LOW	LOW
	Config 4	ON	OFF	ON	LOW	HIGH	LOW
OL at SH3	Config 1	OFF	OFF	OFF	HIGH	HIGH	HIGH
	Config 2	ON	ON	OFF	LOW	LOW	HIGH
	Config 3	OFF	ON	ON	LOW	LOW	LOW
	Config 4	ON	OFF	ON	LOW	LOW	LOW

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## Glossary

## Glossary

### **CAN**

*controller area network (CAN)*

### **ESD**

*electrostatic discharge (ESD)*

A sudden and momentary flow of electric current between two electrically charged objects caused by contact, an electrical short or dielectric breakdown.

### **GND**

*ground (GND)*

### **IC**

*integrated circuit (IC)*

A miniature electronic circuit built on the surface of a thin substrate of a semiconductor material.

### **VS**

*voltage supply (VS)*



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## Revision history

### Revision history

Document version	Date of release	Description of changes
Rev. 1.10	2024-06-21	<ul style="list-style-type: none"><li>• <a href="#">Figure 6</a> updated</li><li>• Editorial changes</li><li>• Glossary added</li></ul>
Rev. 1.00	2020-05-08	<ul style="list-style-type: none"><li>• Initial document release</li></ul>

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